Search Notes

Ap	plic	ati	on	Contr	ol	No.	

Applicant(s)/Patent under Reexamination

10/697,455

YAMAMOTO ET AL.

Examiner

Art Unit

Thomas D. Alunkal

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Class	Subclass	Date	Examiner
369	44.32	6/8/2006	TDA
369	53.19	6/8/2006	TDA

INT	ITERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST-US- PGPUB;USPAT;USOCR;EPO;JPO;D ERWENT;IBM_TDM(see Search History Attached)	6/8/2006	TDA
IEEE/INSPEC/ACM(tilt control using maximum RF envolope value, min, differernce)	6/8/2006	TDA
Inventor Name Seach(Attached)	6/14/2006	TDA